Search Notes					

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/817,249	NAKANO ET AL.	
Examiner	Art Unit	
Ryan D. Walsh	2852	

	SEAR	CHED	
Class	Subclass	Date	Examiner
399	350	9/17/2006	RDW

INT	ERFERENC	E SEARCH	ED
Class	Subclass	Date	Examiner
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SEARCH NO (INCLUDING SEARCH	TES I STRATEGY)
	DATE	EXMR
See EAST search history attached	9/13/2006	RDW
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